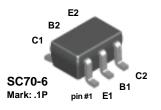


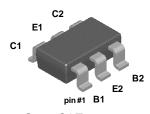
FFB2222A

FMB2222A

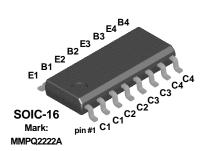
MMPQ2222A



NOTE: The pinouts are symmetrical; pin 1 and pin 4 are interchangeable. Units inside the carrier can be of either orientation and will not affect the functionality of the device.



SuperSOT™-6 Mark: .1P Dot denotes pin #1



NPN Multi-Chip General Purpose Amplifier

This device is for use as a medium power amplifier and switch requiring collector currents up to 500 mA. Sourced from Process 19.

Absolute Maximum Ratings*

 $T_A = 25$ °C unless otherwise noted

Symbol	Parameter	Value	Units
V_{CEO}	Collector-Emitter Voltage	40	V
V _{CBO}	Collector-Base Voltage	75	V
V _{EBO}	Emitter-Base Voltage	5.0	V
Ic	Collector Current - Continuous	500	mA
T _J , T _{stg}	Operating and Storage Junction Temperature Range	-55 to +150	°C

^{*}These ratings are limiting values above which the serviceability of any semiconductor device may be impaired.

NOTES:

1) These ratings are based on a maximum junction temperature of 150 degrees C.

Thermal Characteristics T_A = 25°C unless otherwise noted

Symbol	Characteristic	Max			Units
		FFB2222A	FMB2222A	MMPQ2222A	
P_D	Total Device Dissipation Derate above 25°C	300 2.4	700 5.6	1,000 8.0	mW mW/°C
R _{θJA}	Thermal Resistance, Junction to Ambient Effective 4 Die Each Die	415	180	125 240	°C/W °C/W °C/W

²⁾ These are steady state limits. The factory should be consulted on applications involving pulsed or low duty cycle operations.

(continued)

Electrica	l Chara	cte	ristic	: 5

 $T_A = 25$ °C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
OFF CHAI	DACTEDISTICS					
	RACTERISTICS	II. 40 A I 0	10	ı		V
$V_{(BR)CEO}$	Collector-Emitter Breakdown Voltage*	$I_C = 10 \text{ mA}, I_B = 0$	40			V
V _{(BR)CBO}	Collector-Base Breakdown Voltage	$I_C = 10 \mu A, I_E = 0$	75			V
V _{(BR)EBO}	Emitter-Base Breakdown Voltage	$I_E = 10 \mu A, I_C = 0$	5.0			V
I _{CBO}	Collector Cutoff Current	V _{CB} = 60 V, I _E = 0			10	nA
I _{EBO}	Emitter Cutoff Current	V _{EB} = 3.0 V, I _C = 0			10	nA
	•		•		•	•
ON CHAR	ACTERISTICS					
h _{FE}	DC Current Gain	$I_C = 0.1 \text{ mA}, V_{CE} = 10 \text{ V}$	35			
		$I_C = 1.0 \text{ mA}, V_{CE} = 10 \text{ V}$	50			
		$I_C = 10 \text{ mA}, V_{CE} = 10 \text{ V}$	75		200	
		$I_C = 150 \text{ mA}, V_{CE} = 10 \text{ V}^*$ $I_C = 150 \text{ mA}, V_{CE} = 1.0 \text{ V}^*$	100 50		300	
		$I_C = 130 \text{ mA}, V_{CE} = 1.0 \text{ V}$ $I_C = 500 \text{ mA}, V_{CE} = 10 \text{ V}^*$	40			
V _{CE(sat)}	Collector-Emitter Saturation Voltage*	I _C = 150 mA, I _B = 15 mA	70		0.3	V
V CE(Sat)	Consider Emiliar Saturation Voltage	$I_C = 500 \text{ mA}, I_B = 50 \text{ mA}$			1.0	V
V _{BE(sat)}	Base-Emitter Saturation Voltage*	I _C = 150 mA, I _B = 15 mA			1.2	V
		$I_C = 500 \text{ mA}, I_B = 50 \text{ mA}$			2.0	V
SMALL SI	IGNAL CHARACTERISTICS					
f _T	Current Gain - Bandwidth Product	$I_{C} = 20 \text{ mA}, V_{CE} = 20 \text{ V},$		300		MHz
*1	Current Cam Banawatti Toddot	f = 100 MHz		000		171112
C _{obo}	Output Capacitance	$V_{CB} = 10 \text{ V}, I_E = 0, f = 100 \text{ kHz}$		4.0		pF
C _{ibo}	Input Capacitance	$V_{EB} = 0.5 \text{ V}, I_C = 0, f = 100 \text{ kHz}$		20		pF
				2.0		J.
NF	Noise Figure	$I_C = 100 \mu\text{A}, V_{CE} = 10 \text{V},$		2.0		dB
NF	Noise Figure	$I_C = 100 \mu A$, $V_{CE} = 10 V$, $R_S = 1.0 kΩ$, $f = 1.0 kHz$		2.0		aв
				2.0		αв
SWITCHII	Noise Figure NG CHARACTERISTICS Delay Time			8		ns
SWITCHII	NG CHARACTERISTICS	$R_S = 1.0 \text{ k}\Omega$, $f = 1.0 \text{ kHz}$				
	NG CHARACTERISTICS Delay Time	$R_{S} = 1.0 \text{ k}\Omega, \text{ f} = 1.0 \text{ kHz}$ $V_{CC} = 30 \text{ V}, V_{BE(OFF)} = 0.5 \text{ V},$		8		ns

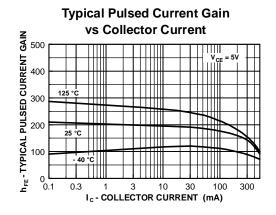
^{*}Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 2.0%

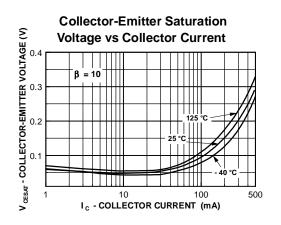
Spice Model

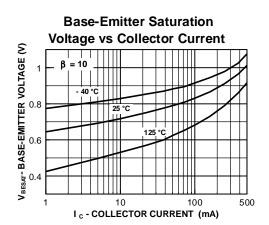
 $NPN \ (Is=14.34f \ Xti=3 \ Eg=1.11 \ Vaf=74.03 \ Bf=255.9 \ Ne=1.307 \ Is=14.34f \ Ikf=.2847 \ Xtb=1.5 \ Br=6.092 \ Nc=2 \ Isc=0 \ Ikr=0 \ Rc=1 \ Cjc=7.306p \ Mjc=.3416 \ Vjc=.75 \ Fc=.5 \ Cje=22.01p \ Mje=.377 \ Vje=.75 \ Tr=46.91n \ Tf=411.1p \ Itf=.6 \ Vtf=1.7 \ Xtf=3 \ Rb=10)$

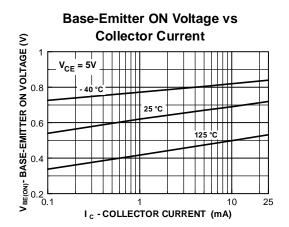
(continued)

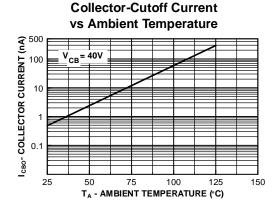
Typical Characteristics

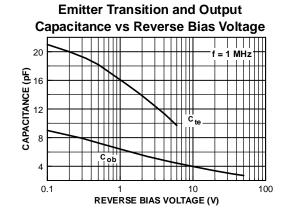








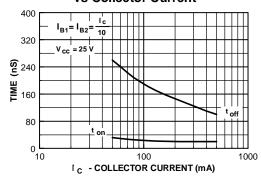




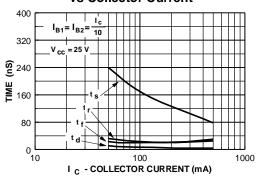
(continued)

Typical Characteristics (continued)

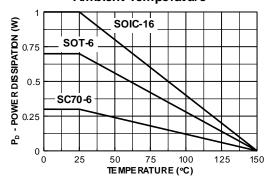
Turn On and Turn Off Times vs Collector Current



Switching Times vs Collector Current

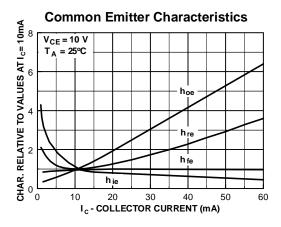


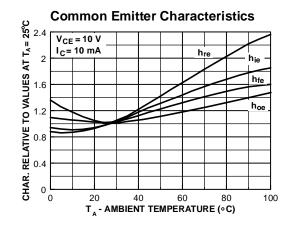
Power Dissipation vs Ambient Temperature

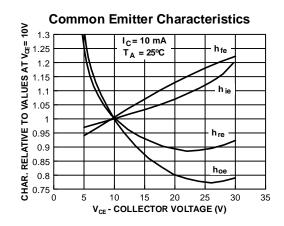


(continued)

Typical Common Emitter Characteristics (f = 1.0kHz)







(continued)

Test Circuits

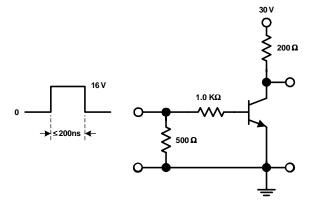


FIGURE 1: Saturated Turn-On Switching Time

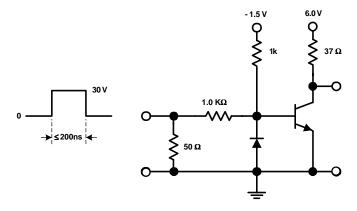


FIGURE 2: Saturated Turn-Off Switching Time

TRADEMARKS

The following are registered and unregistered trademarks Fairchild Semiconductor owns or is authorized to use and is not intended to be an exhaustive list of all such trademarks.

 $ACEx^{TM}$ FASTr™ PowerTrench® SyncFET™ Bottomless™ QFET™ TinyLogic™ GlobalOptoisolator™ QSTM UHC™ CoolFET™ GTO™ **VCX**TM $CROSSVOLT^{TM}$ QT Optoelectronics™ HiSeC™

DOME™ ISOPLANAR™ Quiet Series™

DISCLAIMER

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS.

LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION. As used herein:

1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, or (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in significant injury to the user.

2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

PRODUCT STATUS DEFINITIONS

Definition of Terms

Datasheet Identification	Product Status	Definition
Advance Information	Formative or In Design	This datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary	First Production	This datasheet contains preliminary data, and supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
No Identification Needed	Full Production	This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
Obsolete	Not In Production	This datasheet contains specifications on a product that has been discontinued by Fairchild semiconductor. The datasheet is printed for reference information only.

Mouser Electronics

Authorized Distributor

Click to View Pricing, Inventory, Delivery & Lifecycle Information:

Fairchild Semiconductor: